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Application/Control No.	Applicant(s)/Patent under Reexamination	
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Examiner	Art Unit	
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NVENTORS, PALM, EAST PARENT APPS ION-PATENT LIT (ENCLOSED) EAST-KEYWORDS, USPAT, ISPGPUBS, EPO, DERWENT SEQ ID NO: 28, STIC	8/6/2006	SLW
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